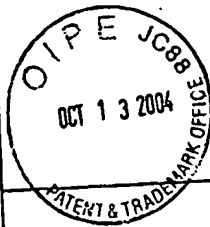


**Form PTO-1449** (modified)  
List of Patents and Publications  
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APPLICANT: Scott C. McLeod

FILING DATE: February 18, 2004

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2819

### U.S. PATENT DOCUMENTS

EXAM. INITIALS	REF. DES	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>h</i>	A1	3,672,215	6/27/72	Stout et al.			
<i>h</i>	A2	3,679,992	7/25/72	Yerman			
	A3	4,228,684	10/21/80	Templin			
	A3.1	4,636,092	01/13/87	Hegyi			
	A4	5,195,827	3/23/93	Audy et al.			
	A5	5,419,637	5/30/95	Frye et al.			
	A6	5,982,221	11/9/99	Tuthill			
	A7	6,008,685	12/28/99	Kunst			
	A8	6,097,239	8/1/00	Miranda, Jr., et al.			
<i>h</i>	A9	6,554,469	4/29/03	Thomson et al.			
<i>h</i>	A10	6,554,470	4/29/03	Zhang et al.			

### FOREIGN PATENT DOCUMENTS

EXAM. INITIALS	REF. DES	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION. YES/NO
<i>h</i>	A11	DE003637520	5/5/88	Germany			
<i>h</i>	A12	EP000498799	5/16/91	PCT			
<i>h</i>	A13	EP000741860	11/13/96	EP			
<i>h</i>	A14	GB002292221	2/14/96	United Kingdom			

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Information Disclosure Statement--PTO 1449 (modified)

**Form PTO-1449** (modified)

List of Patents and Publications  
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ATTY. DOCKET NO: 5707-04700

SERIAL NO: 10/781,063

APPLICANT: Scott C. McLeod

FILING DATE: February 18, 2004

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**U.S. PATENT DOCUMENTS**

EXAM. INITIALS	REF. DES	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE

**FOREIGN PATENT DOCUMENTS**

EXAM. INITIALS	REF. DES	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION. YES/NO

**OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)**

<i>L</i>	A15	Shen-Whan Chen; Trung Duong; Min-Yih Luo; "Channel Temperature Measurement Using Pulse-Gate Method," IEEE Transactions on Microwave Theory and Techniques, Vol. 47, No. 3, March 1999, pp. 362 - 365.
<i>↑</i>	A16	Kaliyugavaradan, S.; Sankaran, P.; Murti, V.G.K.; "Application Of Reciprocal Time Generation Technique To Digital Temperature Measurement," IEEE Transactions on Instrumentation and Measurement, Vol. 43, No. 1, February 1994, pp. 99 - 100.
<i>↑</i>	A17	Cao Hui; Huang Junnai; "Circuit Design and Implementation for Digital Temperature and Humidity Measurement and Control," ASIC, 2001. Proceedings. 4th International Conference on Oct. 23-25 2001, pp.502 - 505.
<i>↓</i>	A18	Michael P. Timko, "A Two-Terminal IC Temperature Tranducer", IEEE JSSC Vol. SC-11, No. 6, December 1976, pgs. 784-788.
<i>↓</i>	A19	Szajda et al. "A Low Noise, High Resolution Silicon Temperature Sensor", IEEE JSSC, Vol. 31, No. 9, September 1996, pgs. 1308-1313.

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